

LINEAR INTEGRATED CIRCUITS

DATA SHEET

The SE/NE 529 is a high speed analog voltage comparator which, for the first time mates state-of-the-art Schottky diode technology with the conventional linear process. This allows simultaneous fabrication of high speed T²L gates with a precision linear amplifier on a single monolithic chip.

FEATURES

- 10 nsec PROPAGATION DELAY
- COMPLEMENTARY OUTPUT GATES
- TTL OR ECL COMPATIBLE OUTPUTS
- WIDE COMMON MODE AND DIFFERENTIAL VOLTAGE RANGE

APPLICATIONS

A/D CONVERSION

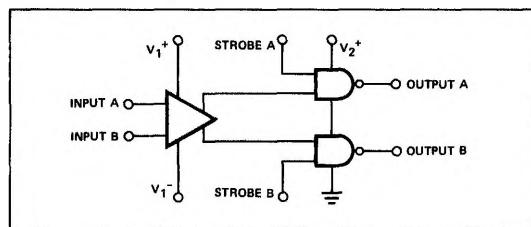
ECL TO TTL INTERFACE

TTL TO ECL INTERFACE

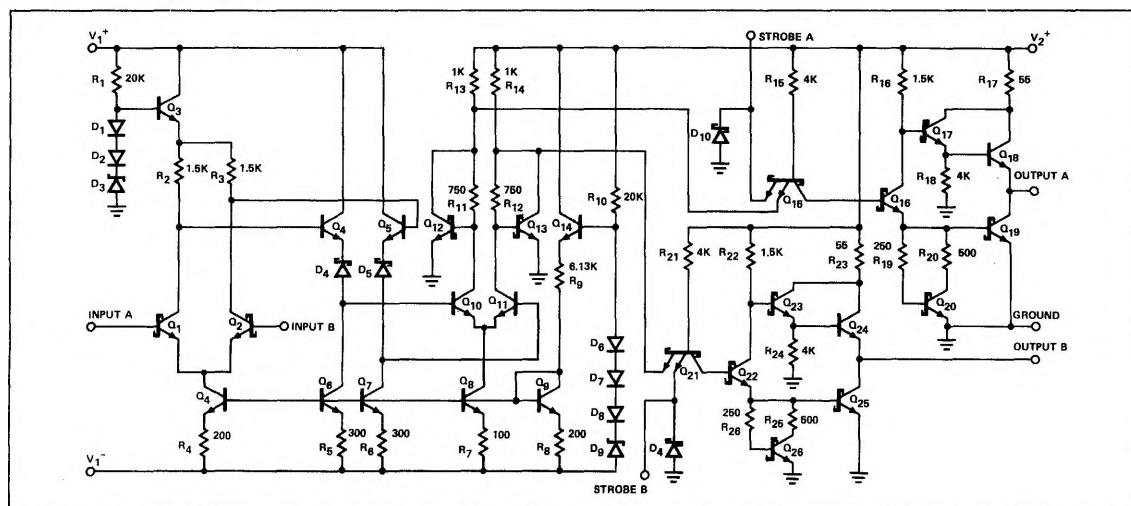
MEMORY SENSING

OPTICAL DATA COUPLING

FUNCTION DIAGRAM



INPUT CIRCUIT



ELECTRICAL CHARACTERISTICS ($V_1^+ = +10V$, $V_2^+ = +5.0V$, $V_1^- = -10V$, $V_{in} = 0V$)

PARAMETER	TEST CONDITIONS	SE 529			NE 529			UNITS
		MIN	TYP	MAX	MIN	TYP	MAX	
INPUT CHARACTERISTICS								
Input Offset Voltage @ $25^\circ C$ over temperature range				4			6	mV
Input Bias Current @ $25^\circ C$ over temperature range	$V_1^+ = 10V$, $V_1^- = -10V$ $V_{in} = 0V$	5	12	36	5	20	50	μA
Input Offset Current @ $25^\circ C$ over temperature range	$V_1^+ = 10V$, $V_1^- = -10V$ $V_{in} = 0V$	2	3	9	2	5	15	μA
Voltage Gain	$T_A = 25^\circ C$	5			5			V/mV
Input Resistance	$T_A = 25^\circ C$, $f = 1$ kHz	10			10			$K\Omega$
GATE CHARACTERISTICS								
Output Voltage "1" State @ $25^\circ C$	$V_2^+ = 4.75V$, $I_{source} = -1mA$	2.5	3.3		2.7	3.3		V
"0" State @ $25^\circ C$	$V_2^+ = 4.75V$, $I_{sink} = 10mA$			0.5			0.5	V
Strobe Inputs								
"0" Input Current	$V_2^+ = 5.25V$, $V_{strobe} = 0.5V$			-2			-2	mA
"1" Input Current @ $25^\circ C$	$V_2^+ = 5.25V$, $V_{strobe} = 2.7V$			50			100	μA
over temperature range				200			200	μA
"0" Input Voltage	$V_2^+ = 4.75V$			0.8			0.8	V
"1" Input Voltage	$V_2^+ = 4.75V$	2.0			2.0			V
Short Circuit Output Current	$V_2^+ = 5.25V$, $V_{out} = 0V$	-40		-100	-40		-100	mA
POWER SUPPLY REQUIREMENTS								
Supply Voltage								
V_1^+		5	10	5		10		V
V_1^-		-6	-10	-6		-10		V
V_2^+		4.5	5	5.5	4.75	5	5.25	V
Supply Current	$V_1^+ = 10V$, $V_1^- = -10V$ $V_2^+ = 5.25V$							
I_1^+	$T_A = 125^\circ C$			3.25				mA
	$T_A = 25^\circ C$			3.75				mA
	$T_A = -55^\circ C$			4.0				mA
	$0^\circ C \leq T_A \leq 70^\circ C$						5	mA
I_1^-	$T_A = 125^\circ C$			7.0				mA
	$T_A = 25^\circ C$			7.5				mA
	$T_A = -55^\circ C$			8.5				mA
	$0^\circ C \leq T_A \leq 70^\circ C$						10	mA
I_2^+	$T_A = 125^\circ C$			15				mA
	$T_A = 25^\circ C$			16				mA
	$T_A = -55^\circ C$			18				mA
	$0^\circ C \leq T_A \leq 70^\circ C$						20	mA
TRANSIENT RESPONSE								
Propagation Delay Time	$V_{in} = 50$ mV overdrive							
$t_{pd}(0)$	$T_A = +25^\circ C$	10	20		10	20		ns
$t_{pd}(1)$	$T_A = +25^\circ C$	12	22		12	22		ns
Delay between Output A and B	$T_A = +25^\circ C$	2	5		2	5		ns
Strobe Delay Time								
Turn On	$T_A = +25^\circ C$	6			6			ns
Turn Off	$T_A = +25^\circ C$	6			6			ns

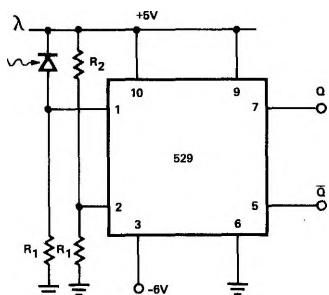
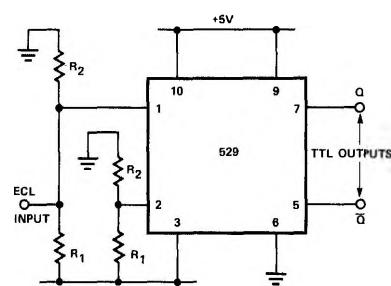
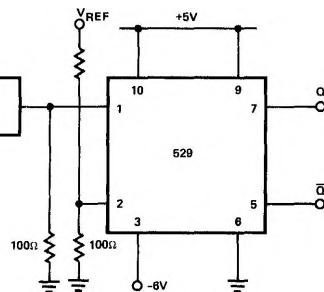
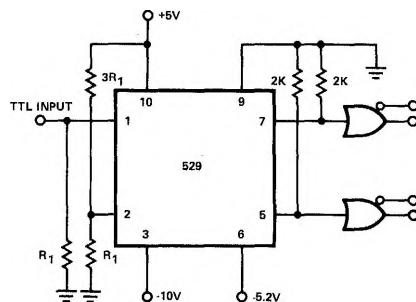
Parameters are guaranteed over the temperature range unless otherwise noted.

APPLICATIONS

One of the main features of the device is that supply voltages (V_1^+ , V_1^-) need not be balanced, as indicated in the following diagrams. For proper operation, however, negative supply (V_1^-) should always be at least five volts more negative than the ground terminal (pin 6). Input Common Mode range should be limited to values of two

volts less than the supply voltages (V_1^+ and V_1^-) up to a maximum of ± 6 volts as supply voltages are increased.

It is also important to note that Output A is in phase with Input A and Output B is in phase with Input B.

TYPICAL APPLICATIONS**PHOTODIODE DETECTOR****ECL TO TTL INTERFACE****MOS MEMORY SENSE AMP****TTL TO ECL INTERFACE**

TYPICAL PERFORMANCE CURVES

